Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/652,342	SHIMOYAMA ET AL.	
Examiner	Art Unit	
José R. Díaz	2815	

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			:

(INCLUDING SEARCH	STRATEGY)
	DATE	EXMR
Mr. Stephen Adrian confirmed ABN of the case	11/28/2006	JRD
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